Supporting Information

UiO-66-NH₂ Fabrics: Role of Trifluoroacetic Acid as Modulator on MOF Uniform Coating on Electrospun Nanofibers and Efficient Decontamination of Chemical Warfare Agent Simulants

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UiO-66-NH₂ powder: 0.233 g of Zirconium tetrachloride (ZrCl₄,) and 0.181 g of BDC-NH₂ were mixed with 0.16 mL of 12 M HCl and 10 mL DMF solvent. After that, benzoic acid (0.244 g) was added to the above solution by ultrasonication until the precursors were completely dissolved. Subsequently, the solution was transferred into 50 mL Teflon-lined autoclave for 48 h at 120 °C. Finally, the sample was washed with DMF and ethanol for three times, respectively and dried under vacuum oven (24 h, 60 \Box). The sample was denoted by UiO-66-NH₂ powder without TFA.

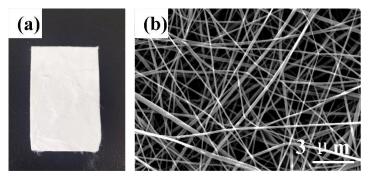


Figure S1. (a) Optical image and (b) SEM image of bulk PAN nanofiber membrane.

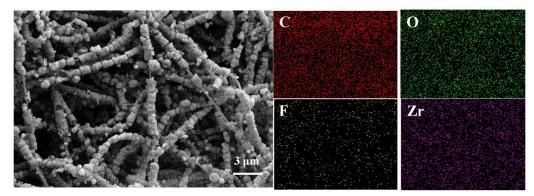


Figure S2. The Element mapping images of C, O, F and Zr in UiO-66-NH₂@PAN-2h.

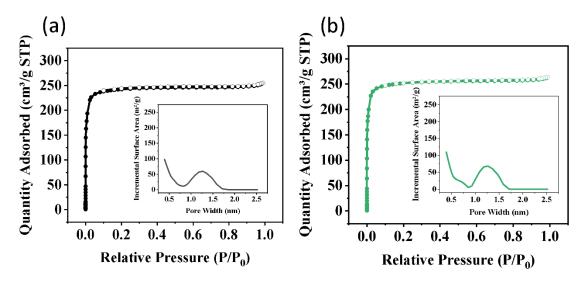


Figure S3. N₂ sorption isotherms of UiO-66-NH₂@PAN-1h (a) and UiO-66-NH₂@PAN-4h (b) the distribution of pore size of inset images.

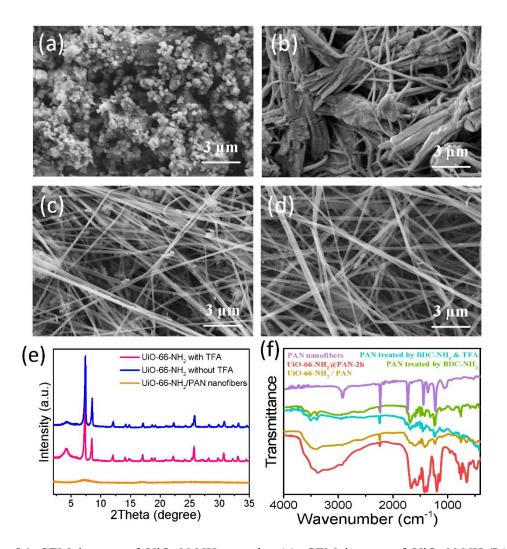


Figure S4. SEM images of UiO-66-NH₂ powder (a); SEM images of UiO-66-NH₂/PAN nanofibers (b), PAN nanofibers only treated by BDC-NH₂ (c), PAN nanofibers treated by BDC-NH₂ and TFA for 2 h (d); XRD patterns (e), FTIR spectrum of different samples (f).

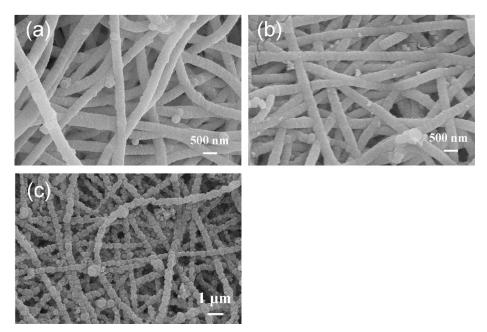


Figure S5. SEM images indicating the changes of PAN fibers surface. After reaction of 10 min (a), 20 min (b) and 30 min (c).

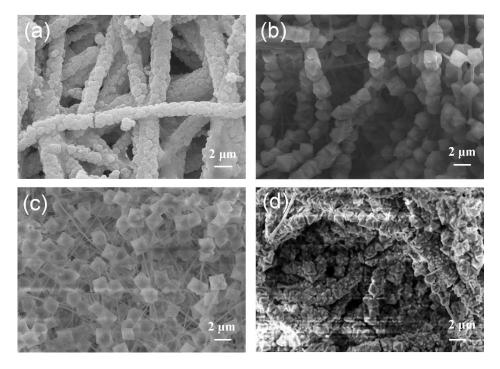


Figure S6. The SEM images of UiO-66-NH₂@TPU (a), MOF-808@PAN (b), UiO-66-NO₂@PAN (c) and UiO-66-NO₂@PVDF (d).

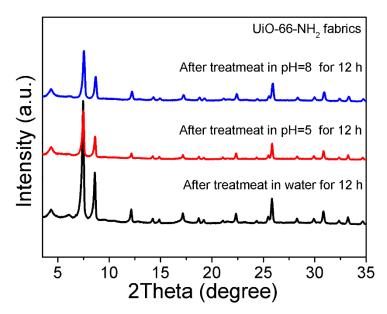


Figure S7. The PXRD of UiO-66-NH₂@PAN-2h after treated with different aqueous solution.

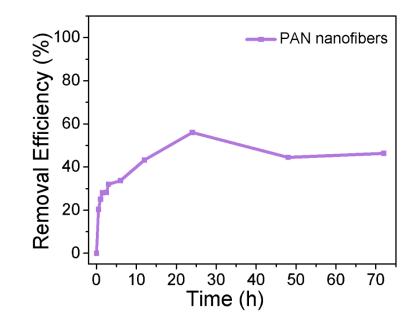


Figure S8. The profiles of removal efficiency for PAN.

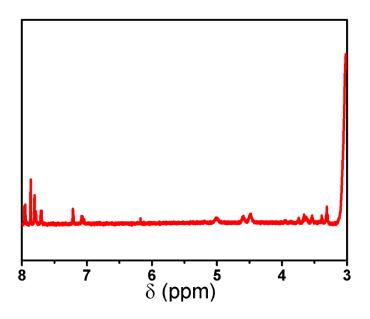


Figure S9. ¹H NMR of UiO-66-NH₂@PAN-2h exposed to CEES for 72 h and digested in $H_2SO_4/DMSO$.

Wavenumber (cm ⁻¹)	Mode	
2935	C-H stretching vibration	
2240	-CN group stretching vibration	
1454	CH ₂ bending vibration	
680, 764	Zr-O	
1569, 1430, 1389	COO-	
3488, 3380, 1626	-NH ₂	

Table S1. FTIR modes of PAN and UiO-66-NH₂@PAN composite materials.

Table S2. The comparison of four samples of BET.

Sample	$S_{BET}(m^2/g)$	Pore volume (cm ³ /g)	Average pore size (nm)
UiO-66-NH2@PAN-1h	816.4	0.395	1.933
UiO-66-NH2@PAN-2h	958.7	0.459	1.916
UiO-66-NH ₂ @PAN-4h	849.6	0.407	1.921

 Table S3. The mass change after washing in different pH.

	Before cleaning m ₁ (mg)	After cleaning12h m ₂ (mg)	Mass loss (%)
Deionized water	10.92	10.03	8.15
NaOH (aq) pH=8.0	13.22	12.54	5.14
HCl (aq) pH=5.0	11.85	11.03	6.92